


Search Notes 	Application/Control No. 09761561	Applicant(s)/Patent Under Reexamination BATARSEH ET AL.
	Examiner Choi, Frank I	Art Unit 1616


Notes	Date	Examiner
-------	------	----------

EAST, STN/CAS, inventor search-Batarseh, Al-Kayed


3/8/05

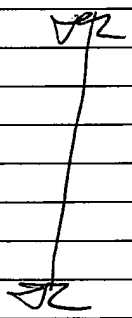
JL

U.S. Patent and Trademark Office	Part of Paper No.: 3/8/2005
----------------------------------	-----------------------------

Interference Searched 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	09761561	BATARSEH ET AL.
	Examiner Choi, Frank I	Art Unit 1616

Class	Sub Class	Date	Examiner
424	613, 614, 616, 617, 618, 620,	3/8/05	JL
514	492, 493, 494, 495, 497, 498,	3/8/05	
424	621, 622, 625, 626, 627, 629,	3/8/05	
424	630, 638, 639, 641, 644, 646,	3/8/05	
424	649, 650, 652, 654, 655, 682,	3/8/05	
514	499, 500, 501, 504, 505, 553,	3/8/05	
514	554, 557, 561, 635, 706, 714, 724,	3/8/05	
424	702, Dig. 6	3/8/2005	JL
U.S. Patent and Trademark Office		Part of Paper No.:	3/8/2005

<p>Searched</p> 	<p>Application/Control No.</p> <p>09761561</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>BATARSEH ET AL.</p>
	<p>Examiner</p> <p>Choi, Frank I</p>	<p>Art Unit</p> <p>1616</p>

Class	Sub Class	Date	Examiner
424	613, 614, 616, 617, 618, 620 ,	3/8/05	
424	621,622, 625, 626,627, 629, 630	3/8/05	
424	638, 639,644, 646, 649, 650, 641	3/8/05	
424	652, 654, 655, 682, 702, Dig. 6	3/8/05	
514	492, 493, 494,495, 497, 498,	3/8/05	
514	499, 500, 501, 504, 505, 553,	3/8/05	
514	554, 557, 561, 635,706, 714	3/8/05	
514	724	3/8/05	

U.S. Patent and Trademark Office	Part of Paper No.: 3/8/2005
----------------------------------	-----------------------------